

N-Channel, Logic Level Enhancement Mode Field Effect Transistor NDB5060L

General Description

These logic level N-Channel enhancement mode power field effect transistors are produced using **onsemi**'s proprietary, high cell density, DMOS technology. This very high density process has been especially tailored to minimize on-state resistance, provide superior switching performance, and withstand high energy pulses in the avalanche and commutation modes. These devices are particularly suited for low voltage applications such as automotive, DC-DC converters, PWM motor controls, and other battery powered circuits where fast switching, low in-line power loss, and resistance to transients are needed.

Features

- 26 A. 60 V
 - $R_{DS(ON)} = 0.05 \text{ m}\Omega @ V_{GS} = 5 \text{ V}$
 - $R_{DS(ON)} = 0.035 \text{ m}\Omega @ V_{GS} = 10 \text{ V}$
- Critical DC Electrical Parameters Specified at Elevated Temperature
- Rugged Internal Source–Drain Diode Can Eliminate the Need for an External Zener Diode Transient Suppressor
- 175°C Maximum Junction Temperature Rating
- High Density Cell Design for Extremely Low R_{DS(ON)}
- D²PAK Package for Both Through Hole and Surface Mount Applications

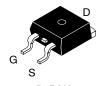
ABSOLUTE MAXIMUM RATINGS $T_C = 25^{\circ}C$ unless otherwise noted

Symbol	Rating	Value	Unit
V _{DSS}	Drain-Source Voltage	60	V
V_{DGR}	Drain-Gate Voltage ($R_{GS} \le 1 \text{ M}\Omega$)	60	V
V_{GSS}	Drain–Source Voltage – Continuous – Nonrepetiti (t _p < 50 μs)	±16 ±25	V
Ι _D	Drain Current - Continuous - Pulsed	26 78	Α
P_{D}			W
	– Derate above 25°C	0.45	W/°C
T_J, T_{STG}	Operating and Storage Temperature Range	-65 to 175	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

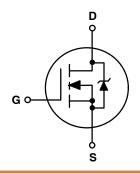
THERMAL CHARACTERISTICS

Symbol	Rating	Value	Unit	
$R_{\theta JC}$	Thermal Resistance, Junction-to-Case	2.2	°C/W	
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient	62.5	°C/W	

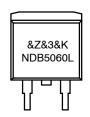


D2PAK-3 (TO-263, 3-LEAD) CASE 418AJ

N-CHANNEL MOSFET



MARKING DIAGRAM



&Z = Assembly Plan Code

&3 = 3-Digit Date Code Code (Year & Week)

&K = 2-Digits Lot Run Traceability Code

NDB5060L = Specific Device Code

ORDERING INFORMATION

Device	Package	Shipping [†]		
NDB5060L	D2PAK-3 (Pb-Free)	800 / Tape & Reel		

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specification Brochure, BRD8011/D.

ELECTRICAL CHARACTERISTICS ($T_C = 25^{\circ}C$ unless otherwise specified)

Symbol	Parameter	Condition	Min	Тур	Max	Unit	
DRAIN-SO	URCE AVALANCHE RATINGS (Note 1)						
W _{DSS}	Single Pulse Drain-Source Avalanche Energ	gy V _{DD} = 30 V, I _D = 26 A	-	_	100	mJ	
I _{AR}	Maximum Drain-Source Avalanche Current	•	-	-	26	Α	
OFF CHAR	ACTERISTICS						
BV_{DSS}	Drain-Source Breakdown Voltage	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$	60	_	-	V	
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} = 60 V, V _{GS} = 0 V	-	_	250	μΑ	
		$V_{DS} = 60 \text{ V}, V_{GS} = 0 \text{ V}, T_{J} = 125^{\circ}\text{C}$	-	-	1	mA	
I _{GSSF}	Gate-Body Leakage, Forward	V _{GS} = 16 V, V _{DS} = 0 V	-	-	100	nA	
I _{GSSR}	Gate-Body Leakage, Reverse	V _{GS} = -16 V, V _{DS} = 0 V	-	-	-100	nA	
ON CHARA	CTERISTICS (Note 1)						
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_D = 250 \mu A$	1 1.4 2		2	V	
		$V_{DS} = V_{GS}$, $I_D = 250 \mu A$, $T_J = 125^{\circ}C$	0.65	1	1.5	7	
R _{DS(ON)}	Static Drain-Source On-Resistance	V _{GS} = 5 V, I _D = 13 A	-	0.042	0.05	Ω	
, ,		V _{GS} = 5 V, I _D = 13 A, T _J = 125°C	-	0.07	0.08		
		V _{GS} = 10 V, V _{DS} = 13 A	-	0.031	0.035		
I _{D(on)}	On-State Drain Current	V _{GS} = 5 V, V _{DS} = 10 V	26	-	-	Α	
9FS	Forward Transconductance	V _{DS} = 10 V, I _D = 13 A	-	16	-	S	
DYNAMIC (CHARACTERISTICS						
C _{iss}	Input Capacitance	V _{DS} = 30 V, V _{GS} = 0 V,	-	840	-	pF	
C _{oss}	Output Capacitance	f = 1.0 MHz	-	230	-	pF	
C _{rss}	Reverse Transfer Capacitance		-	75	-	pF	
SWITCHING	G CHARACTERISTICS (Note 1)	•					
t _{D(on)}	Turn - On Delay Time	$V_{DD} = 30 \text{ V}, I_D = 26 \text{ A},$	-	13	20	nS	
t _r	Turn – On Rise Time	$V_{GS} = 5 \text{ V}, R_{GEN} = 30 \Omega,$ $R_{GS} = 30 \Omega$	-	200	400	nS	
t _{D(off)}	Turn – Off Delay Time		-	45	80	nS	
tf	Turn – Off Fall Time		-	102	200	nS	
Qg	Total Gate Charge	V _{DS} = 24 V,	-	17	24	nC	
Q _{gs}	Gate-Source Charge	$I_D = 26 \text{ A}, V_{GS} = 5 \text{ V}$	-	4	-	nC	
Q _{gd}	Gate-Drain Charge		-	10	-	nC	
	URCE DIODE CHARACTERISTICS						
I _S	Maximum Continuos Drain-Source Diode Forward Current			-	26	Α	
I _{SM}	Maximum Pulsed Drain-Source Diode Forward Current		-	-	78	Α	
V _{SD}	Drain-Source Diode Forward Voltage	V _{GS} = 0 V, I _S = 13 A (Note 1)	-	0.9	1.3	V	
t _{rr}	Reverse Recovery Time	$V_{GS} = 0 \text{ V, } I_F = 26 \text{ A,}$ $dI_F/dt = 100 \text{ A/}\mu\text{s}$		54	120	ns	
I _{rr}	Reverse Recovery Current			2.1	8	Α	

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

1. Pulse Test: Pulse Width $\leq 300 \,\mu s$, Duty Cycle $\leq 2.0\%$.

TYPICAL CHARACTERISTICS

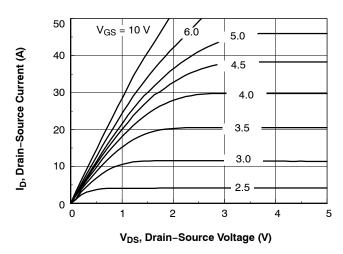
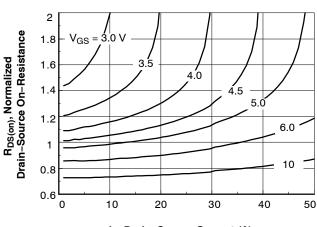


Figure 1. On-Region Characteristics



I_D, Drain-Source Current (A)

Figure 2. On-Resistance Variation with Gate Voltage and Drain Current

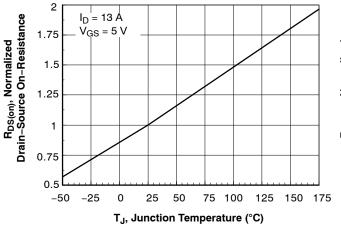


Figure 3. On–Resistance Variation with Temperature

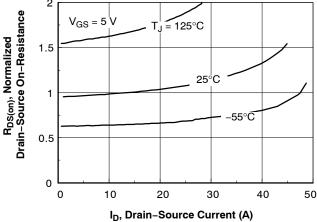


Figure 4. On-Resistance Variation with Drain Current and Temperature

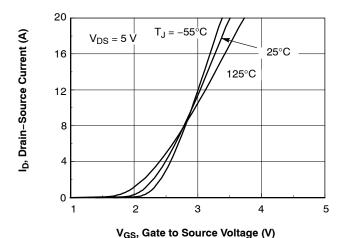


Figure 5. Transfer Characteristics

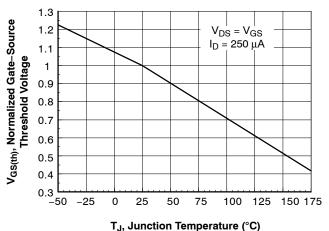


Figure 6. Gate Threshold Variation with Temperature

TYPICAL CHARACTERISTICS (Continued)

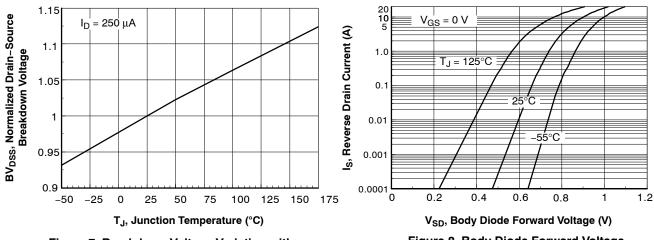


Figure 7. Breakdown Voltage Variation with **Temperature**

Figure 8. Body Diode Forward Voltage Variation with Current and Temperature

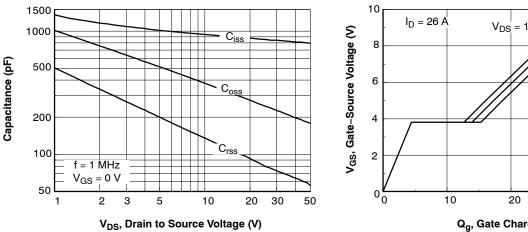


Figure 9. Capacitance Characteristics

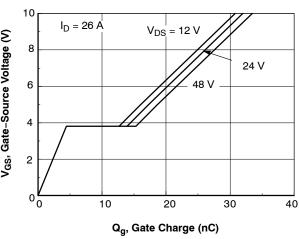


Figure 10. Gate Charge Characteristics

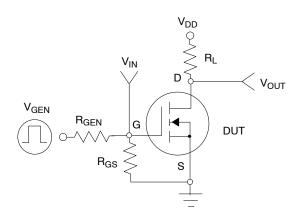


Figure 11. Switching Test Circuit

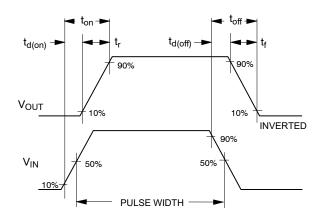
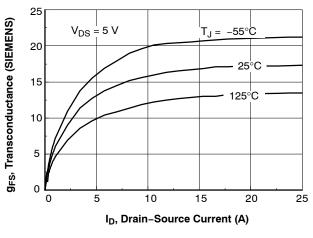


Figure 12. Switching Waveforms

TYPICAL CHARACTERISTICS (Continued)



100 R_{DS(ON)} LIMIT 10 μs 60 ID, Drain-Source Current (A) 30 1 ms 10 ms 10 100 ms 5 V_{GS} = 5 V SINGLE PULSE ЪС $R_{\theta JC} = 2.2^{\circ}C/W$ $T_C = 25^{\circ}C$ 2 1 0.5 20 40 60 80 V_{DS}, Drain to Source Voltage (V)

Figure 13. Transconductance Variation with Drain Current and Temperature

Figure 14. Maximum Safe Operating Area

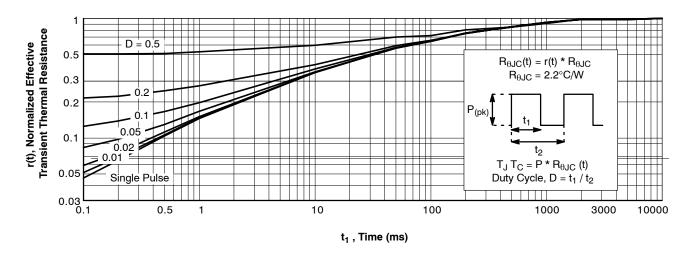


Figure 15. Transient Thermal Response Curve





0.653

2x 0.063

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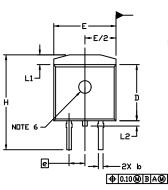
0.366

0.169

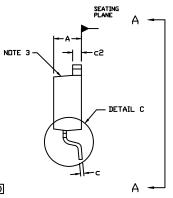
0.100 PITCH

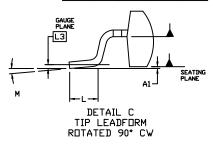
- DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 2009.
- 2. CONTROLLING DIMENSION: INCHES
- 3. CHAMFER OPTIONAL.
- 4. DIMENSIONS D AND E DO NOT INCLUDE MOLD FLASH. MOLD FLASH SHALL NOT EXCEED 0.005 PER SIDE. THESE DIMENSIONS ARE MEASURED AT THE DUTERMOST EXTREMES OF THE PLASTIC BODY AT DATUM H.
- 5. THERMAL PAD CONTOUR IS OPTIONAL WITHIN DIMENSIONS E, L1, D1, AND E1.
- 6. OPTIONAL MOLD FEATURE.
- 7. ①,② ... OPTIONAL CONSTRUCTION FEATURE CALL DUTS.

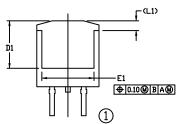
	INCHES		MILLIMETERS		
DIM	MIN.	MAX.	MIN.	MAX.	
Α	0.160	0.190	4.06	4.83	
A1	0.000	0.010	0.00	0.25	
b	0.020	0.039	0.51	0.99	
c	0.012	0.029	0.30	0.74	
c2	0.045	0.065	1.14	1.65	
D	0.330	0.380	8.38	9.65	
D1	0.260		6.60		
E	0.380	0.420	9.65	10.67	
E1	0.245		6.22		
e	0.100 BSC		2.54 BSC		
Ξ	0.575	0.625	14.60	15.88	
L	0.070	0.110	1.78	2.79	
L1		0.066		1.68	
L2		0.070		1.78	
L3	0.010 BSC		0.25 BSC		
М	0*	8*	0*	8•	



RECOMMENDED MOUNTING FOOTPRINT



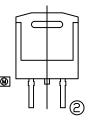




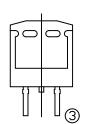
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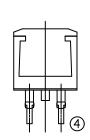
AWLYWWG

VIEW A-A



GENERIC MARKING DIAGRAMS*





VIEW A-A

OPTIONAL CONSTRUCTIONS

XXXXXX

XXYMW

SSG

AYWW

XXXXXXXXX

Rectifier

AKA

XXXXXX = Specific Device Code

A = Assembly Location

WL = Wafer Lot Y = Year

WW = Work Week

W = Week Code (SSG)

M = Month Code (SSG)

G = Pb-Free Package

AKA = Polarity Indicator

*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot " • ", may or may not be present. Some products may not follow the Generic Marking.

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AYWW

Standard

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DESCRIPTION:

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